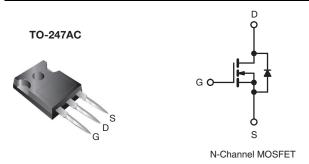


Vishay Siliconix

## **Power MOSFET**

PRODUCT SUMMARY					
V <sub>DS</sub> (V)	400				
$R_{DS(on)}(\Omega)$	V <sub>GS</sub> = 10 V 0.20				
Q <sub>g</sub> (Max.) (nC)	110				
Q <sub>gs</sub> (nC)	28				
Q <sub>gd</sub> (nC)	45				
Configuration	Single				



#### **FEATURES**

- Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Isolated Central Mounting Hole
- Dynamic dV/dt Rated
- Repetitive Avalanche Rated
- Compliant to RoHS Directive 2002/95/EC

#### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge over convertional MOSFETs. Utilizing advanced MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of MOSFETs offer the designer a new standard in power transistors for switching applications. The TO-247AC package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220AB devices. The TO-247AC is similar but superior to the earlier TO-218 package because of its isolated mounting hole.

ORDERING INFORMATION			
Package	TO-247AC		
Lead (Pb)-free	IRFP360LCPbF		
Lead (PD)-IIee	SiHFP360LC-E3		
SnPb	IRFP360LC		
SILL	SiHFP360LC		

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			$V_{DS}$	400	V	
Gate-Source Voltage			$V_{GS}$	± 30	V	
Continuous Drain Current	Vac at 10 V	$T_{\rm C} = 25  ^{\circ}{\rm C}$ $T_{\rm C} = 100  ^{\circ}{\rm C}$	I_	23		
Continuous Brain Guirent	VGS at 10 V	$T_C = 100 ^{\circ}C$	ID	14	Α	
Pulsed Drain Current <sup>a</sup>			I <sub>DM</sub>	91		
Linear Derating Factor				2.2	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>			E <sub>AS</sub>	1200	mJ	
Repetitive Avalanche Currenta			I <sub>AR</sub>	23	Α	
Repetitive Avalanche Energy <sup>a</sup>			E <sub>AR</sub>	28	mJ	
Maximum Power Dissipation $T_C = 25  ^{\circ}C$			$P_{D}$	280	W	
Peak Diode Recovery dV/dt <sup>c</sup>			dV/dt	4.0	V/ns	
Operating Junction and Storage Temperature Range			T <sub>J</sub> , T <sub>stq</sub>	- 55 to + 150	- °C	
Soldering Recommendations (Peak Temperature) for 10 s				300 <sup>d</sup>	7	
Mounting Torque	6 22 or N	6-32 or M3 screw		10	lbf ⋅ in	
Mounting Torque	0-32 of IVIS Screw			1.1	N⋅m	

#### Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b.  $V_{DD}$  = 25 V, starting  $T_J$  = 25 °C, L = 4.0 mH,  $R_g$  = 25  $\Omega$ ,  $I_{AS}$  = 23 A (see fig. 12).
- c.  $I_{SD} \le 23$  A,  $dI/dt \le 170$  A/µs,  $V_{DD} \le V_{DS}$ ,  $T_J \le 150$  °C.
- d. 1.6 mm from case.

<sup>\*</sup> Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP360LC, SiHFP360LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNI					
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	40		
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W	
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.45		

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static					•	•	
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		400	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	:o 25 °C, I <sub>D</sub> = 1 mA	-	0.49	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	<sub>GS</sub> , I <sub>D</sub> = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	<sub>S</sub> = ± 20 V	-	-	± 100	nA
Zero Gate Voltage Drain Current	I <sub>DSS</sub>		00 V, V <sub>GS</sub> = 0 V V <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	25 250	μA
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	$V_{GS} = 320 \text{ V}, \text{ V}$	$I_D = 14 \text{ Ab}$	-	-	0.20	Ω
Forward Transconductance	9 <sub>fs</sub>		60 V, I <sub>D</sub> = 14 A <sup>b</sup>	13	-	-	S
Dynamic							
Input Capacitance	C <sub>iss</sub>		0.1/	-	3400	_	
Output Capacitance	C <sub>oss</sub>		$_{GS} = 0 \text{ V},$ $_{OS} = 25 \text{ V},$	-	540	-	pF
Reverse Transfer Capacitance	C <sub>rss</sub>	f = 1.0 I	f = 1.0 MHz, see fig. 5		42	-	† '
Total Gate Charge	Qg	V <sub>GS</sub> = 10 V		-	-	110	nC
Gate-Source Charge	$Q_{gs}$			-	-	28	
Gate-Drain Charge	Q <sub>gd</sub>		See fig. 6 drid 16	-	-	45	1
Turn-On Delay Time	t <sub>d(on)</sub>	$V_{DD} = 200 \text{ V, } I_D = 23 \text{ A },$ $R_g = 4.3 \ \Omega, \ R_D = 7.9 \ \Omega, \ \text{see fig. } 10^b$		-	16	-	- ns
Rise Time	t <sub>r</sub>			-	75	-	
Turn-Off Delay Time	t <sub>d(off)</sub>			-	42	-	
Fall Time	t <sub>f</sub>			-	50	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s				l		
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	23	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	92	A
Body Diode Voltage	V <sub>SD</sub>	T <sub>J</sub> = 25 °C, I <sub>S</sub> = 23 A, V <sub>GS</sub> = 0 V <sup>b</sup>		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T 05 %0 1	00 A 41/4+ 400 A/b	-	400	600	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>	$T_{J} = 25  ^{\circ}\text{C}, I_{F} = 23  \text{A}, dI/dt = 100  \text{A/}\mu\text{s}^{\text{b}}$		-	5.7	8.6	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-		-on is do	minated b	by L <sub>S</sub> and	L <sub>D</sub> )

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

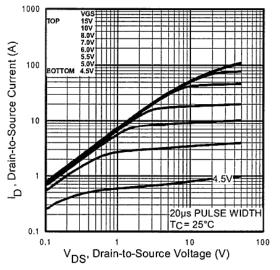


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

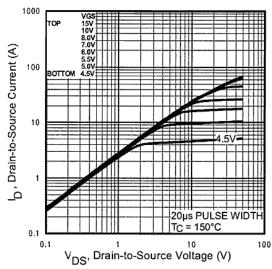


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

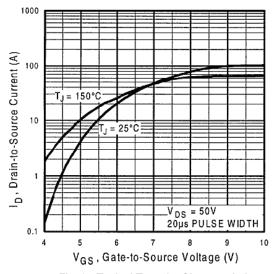


Fig. 3 - Typical Transfer Characteristics

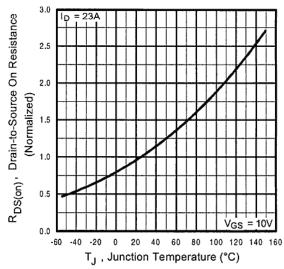


Fig. 4 - Normalized On-Resistance vs. Temperature

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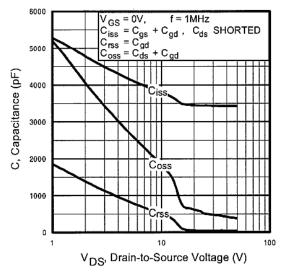


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

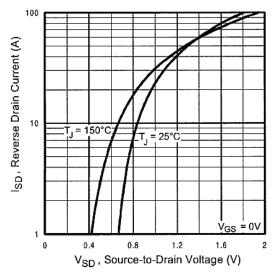


Fig. 7 - Typical Source-Drain Diode Forward Voltage

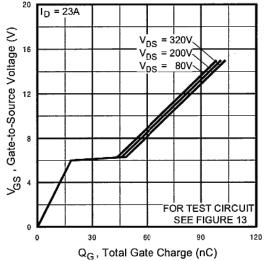


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

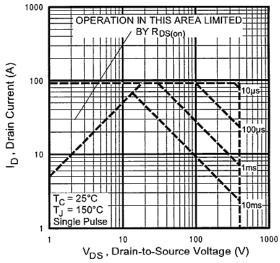


Fig. 8 - Maximum Safe Operating Area



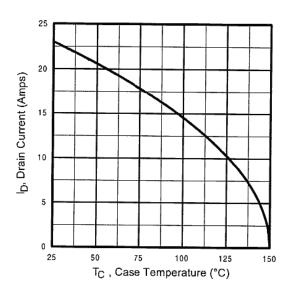


Fig. 9 - Maximum Drain Current vs. Case Temperature

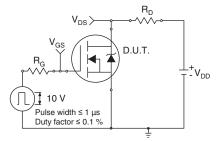


Fig. 10a - Switching Time Test Circuit

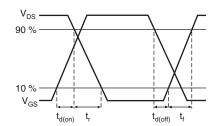


Fig. 10b - Switching Time Waveforms

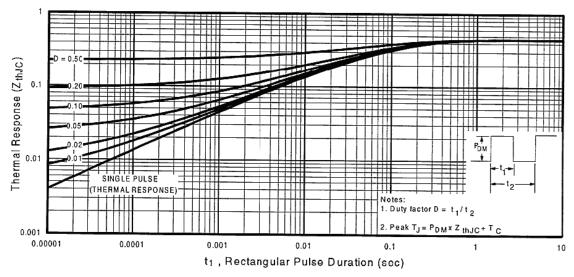
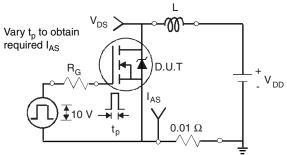
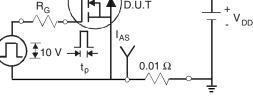


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

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 $V_{DS}$  $V_{DD}$ 

Fig. 12a - Unclamped Inductive Test Circuit

Fig. 12b - Unclamped Inductive Waveforms

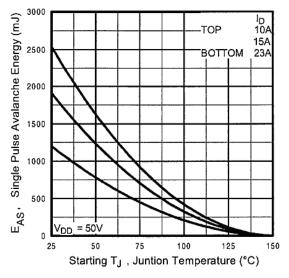


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

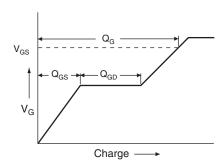


Fig. 13a - Basic Gate Charge Waveform

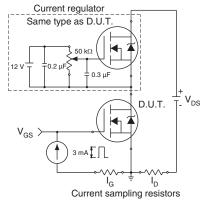
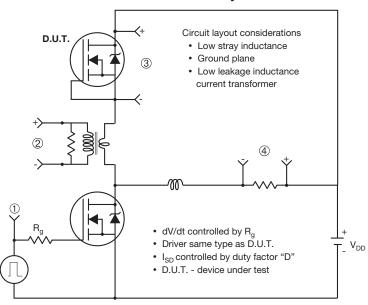


Fig. 13b - Gate Charge Test Circuit



#### Peak Diode Recovery dV/dt Test Circuit



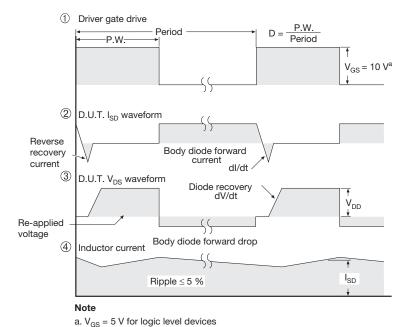


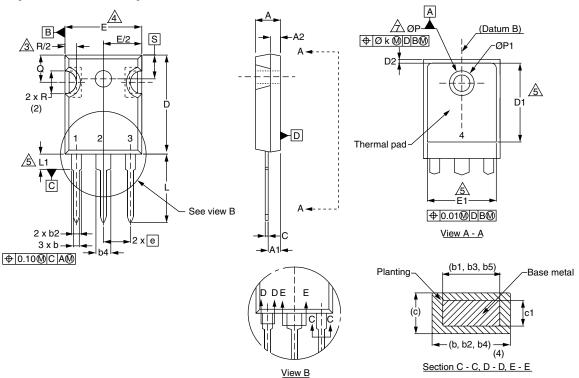
Fig. 14 - For N-Channel

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## **TO-247AC (HIGH VOLTAGE)**



	MILLIMETERS		INCHES	
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.65	5.31	0.183	0.209
A1	2.21	2.59	0.087	0.102
A2	1.50	2.49	0.059	0.098
b	0.99	1.40	0.039	0.055
b1	0.99	1.35	0.039	0.053
b2	1.65	2.39	0.065	0.094
b3	1.65	2.37	0.065	0.093
b4	2.59	3.43	0.102	0.135
b5	2.59	3.38	0.102	0.133
С	0.38	0.86	0.015	0.034
c1	0.38	0.76	0.015	0.030
D	19.71	20.70	0.776	0.815
D1	13.08	-	0.515	-

	MILLIMETERS		INCHES		
DIM.	MIN.	MAX.	MIN.	MAX.	
D2	0.51	1.30	0.020	0.051	
Е	15.29	15.87	0.602	0.625	
E1	13.72	-	0.540	-	
е	5.46	5.46 BSC		0.215 BSC	
Øk	0.254		0.010		
L	14.20	16.10	0.559	0.634	
L1	3.71	4.29	0.146	0.169	
N	7.62	7.62 BSC			
ØΡ	3.56	3.66	0.140	0.144	
Ø P1	-	7.39	-	0.291	
Q	5.31	5.69	0.209	0.224	
R	4.52	5.49	0.178	0.216	
S	5.51 BSC		0.217 BSC		

ECN: S-81920-Rev. A, 15-Sep-08

DWG: 5971

### Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Contour of slot optional.
- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outermost extremes of the plastic body.
- 4. Thermal pad contour optional with dimensions D1 and E1.
- 5. Lead finish uncontrolled in L1.
- 6. Ø P to have a maximum draft angle of 1.5 to the top of the part with a maximum hole diameter of 3.91 mm (0.154").
- 7. Outline conforms to JEDEC outline TO-247 with exception of dimension  $\ensuremath{\text{c}}.$

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Revision: 15-Sep-08
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